

IEC TS

63107

**Integration of arcing fault mitigation
devices into power switchgear and control
gear assemblies according to IEC61439-2**



Welcome



Cristian La Salvia

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Member of CEI CT121 (mirror committee of IEC SC121A,SC121B)

Member of CEI CT320 LVDC (mirror committee of IEC SyC LVDC)

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Welcome to LV Webinar, 16 April 2020

Agenda

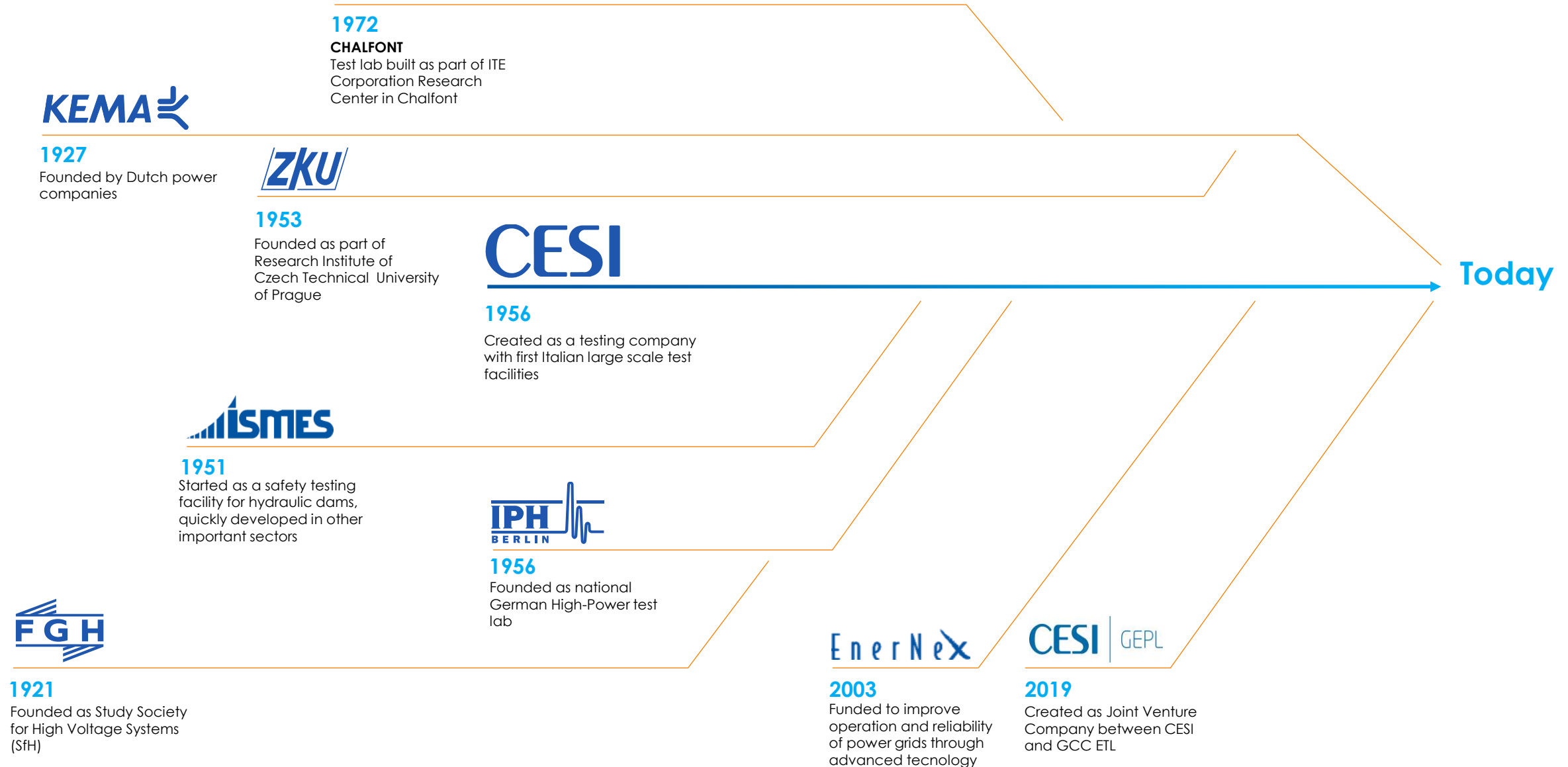
- 09:45 – 10.00 Webinar introduction and CESI presentation (*C.La Salvia*)
- 10:00 – 10:40 LV Technical seminar (*R.Borchert*)
- 10:45 – 11.00 Q&A Session and conclusion

LIVE Registration and today presentation will be available for download in the CESI website, in the next days

www.cesi.it/webinars



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Professionals



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Clients



70+
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ISMES

Renewable Engineering, Remediation, Compliance and Monitoring Services to Drive Circular Economy

Space Solar Cells



CESI

Production of Advanced Multi-junction Solar Cells for Space Applications

30.000 MVA, Next to Our Clients

Arnhem, NL



13.000 MVA

- **Short Circuit HV** up to 1200 kV, 100 kA
- **High Power Trafo** up to 800 kV
- **Dielectric Test HV** up to 550 kV
- **Cable Prequalification** up to 550 kV
- **Temperature Rise** up to 25 kA

Milan, IT



4.000 MVA

- **Short Circuit HV** up to 420 kV, 63 kA
- **Direct Test** up to 36kV/31.5kA
- **Dielectric Test HV** up to 1.600 kVac
- **Cable Prequalification** up to 800kV
- **Temperature Rise** up to 10kA

Berlin, DE



3.000 MVA

- **Short Circuit LV** to 250kAac/150kAdc
- **Direct Test** up to 36kV/25kA
- **Dielectric Test HV** up to 550 kV
- **Cable Prequalification** up to 500 kV
- **Temperature Rise** up to 50kA

Prague, CZ



2.500 MVA

- **Short Circuit MV** up to 36 kV, 25 kA
- **Power arc insulators** up to 63 kA
- **Power Trafo** up to 230 kV, 63 MVA
- **Short-time current** up to 280 kA/2.5s

Mannheim, DE



800 MVA

- **HVDC cable** up to 600 kV
- **Direct Test short-circuit** up to 800 MVA
- **Dielectric Test HV** up to 800 kV
- **Cable Prequalification** up to 400 kV
- **Pollution test** up to 600 kV

Chalfont, USA



3.200 MVA

- **Short Circuit MV** up to 36 kV, 25 kA
- **Short Circuit LV** up to 300 kA
- **Dielectric Test HV** up to 245 kV
- **Temperature Rise** up to 30 kA

Dammam, KSA



2.500 MVA

Under Construction

- **Short Circuit HV** up to 550 kV/63 kA
- **Direct Test** up to 40kV/80kA
- **Dielectric Test HV** up to 1.600 kVac
- **Cable Prequalification** up to 800 kV
- **Short Circuit LV** up to 250kAac/150kAdc

Low voltage Expertise

DC Switchgear and assemblies for railways application



Berlin

Power tests up to 200MVA
Voltage up to 8kV DC

According to
EN50123-IEC61992
EN50526 IEC60310 (EN60310)
IEC60077 (EN60077) IEC 61287-1
and many others

AC/DC Switchgear assemblies



Berlin, Prague, Chalfont

All Type Test up to 6300 A

According to IEC61439-1,
IEC61921, IEC60146 and many
other IEC standard
UL508/UL845/UL98/
UL891/UL681/CSA C22

AC/DC Circuit breakers and fuses



Berlin, Chalfont

Complete type test sequence
according to IEC60947,
IEC60898 and many others
Overload tests up to 10kA
AC 1ph and 3ph

UL248/UL1077/UL1066/UL489

AC/DC Power tests



Berlin, Chalfont

Making and Breaking capacity
test up to 180kA
Short-circuit withstand current
up to 200kA
Internal arc test

According to IEC61439-
IEC61641, IEEE and many others

A brand new Low Voltage standard



IEC TS 63107 ED1: Integration of arcing fault mitigation devices into power switchgear and control-gear assemblies (PSC-ASSEMBLIES) according to IEC61439-2

Ronald Borchert – LV Senior test engineer



Member of committees

IEC/SC121B Low Voltage Switchgear and controlgear assemblies

PT63107: Integration of arc fault mitigation system

DKE UK 431.1 Low Voltage switchgear and controlgear assemblies

DKE UK 431.1.4

1. Integration in the international standard system

2. Scope

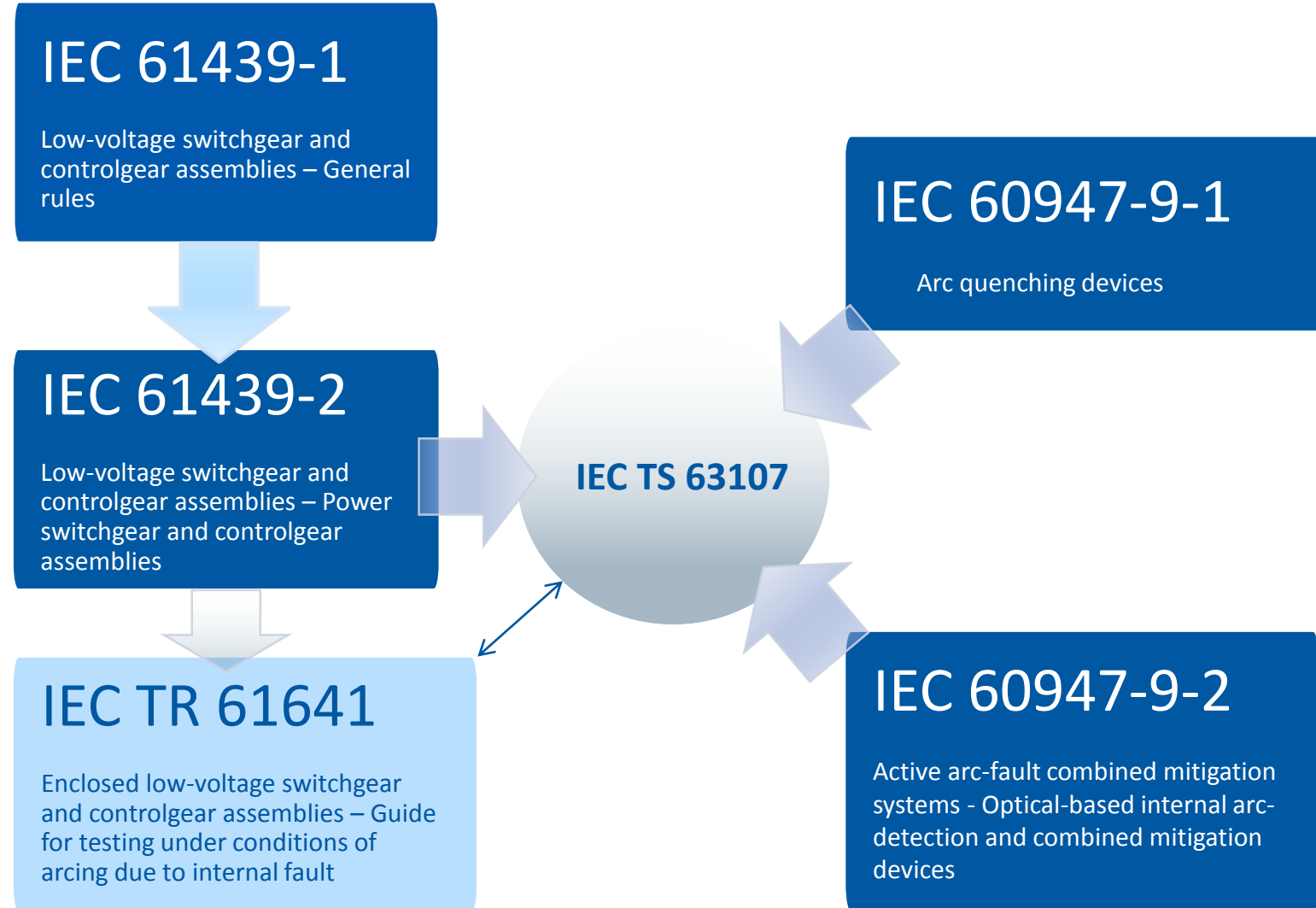
3. Components and basic structure

4. Protected and non-protected areas

5. Design verification

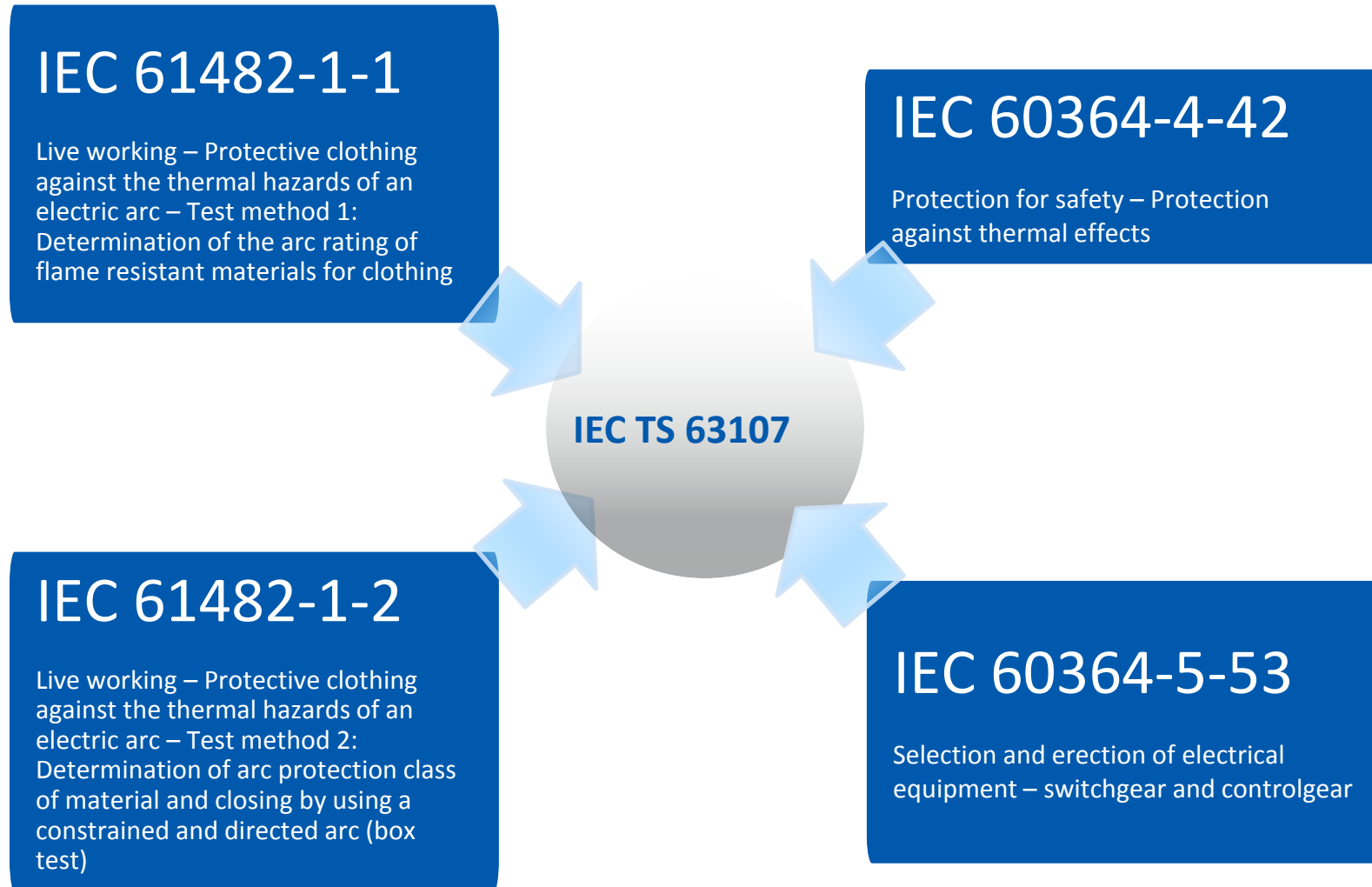
Integration in the international standard system

Product standards



Integration in the international standard system

Standards for protective measures and erection of electrical equipment



1. Integration in the international standard system

2. Scope

3. Components and basic structure

4. Protected and non-protected areas

5. Design verification

- The TS states requirements for integration and testing of IAMS in Low-voltage PSC-assemblies according to IEC 61439-2 to demonstrate their correct operation.
- It does not address personnel safety or damage to the PSC-assembly. These requirements are dealt with IEC TR 61641.
- IAMS consist of control devices (IACD) **and** arc-fault reduction devices (IARD) complying with their relevant product standards.
- Requirements with respect to construction and performance as well as to testing for the reliable function of an IAMS under built-in conditions are addressed .

1. Integration in the international standard system

2. Scope

3. Components and basic structure

4. Protected and non-protected areas

5. Design verification

IAMS (Internal Arc-fault Mitigation System)

IACD

Internal Arc-fault Control
Device

Sensors

Interfaces

Control unit

IARD

Internal Arc-fault Reduction
Device

AQD (Arc Quenching Device)
in connection with a SCPD

IALD (Internal Arc-fault Limitation
Device),
but no SCPD

SCPD

Note: IACD and IARD can be one combined device.

And now it's time for fun.....



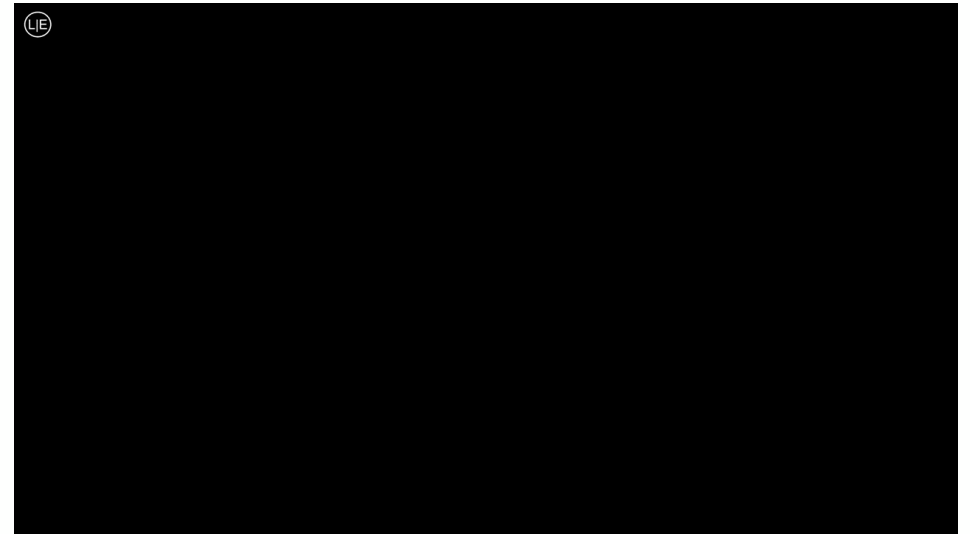
Scan with your **Mobile** the **QR Code**
and **answer** the **questions live** within
2 minutes!



And now it's time for fun.....



Scan with your **Mobile** the **QR Code**
and **answer** the **questions live** within
90 seconds!



1. Integration in the international standard system

2. Scope

3. Components and basic structure

4. Protected and non-protected areas

5. Design verification

Protected and non-protected areas

There can be IAMS-protected and unprotected areas within a switchgear and controlgear assembly.

An IAMS-protected area has to meet the following behavioral requirements:

- The detection of an arcing fault is guaranteed.
- Unintentional tripping (e.g. caused by a switching arc) is prevented.
- The detected arcing fault is limited and ultimately extinguished.

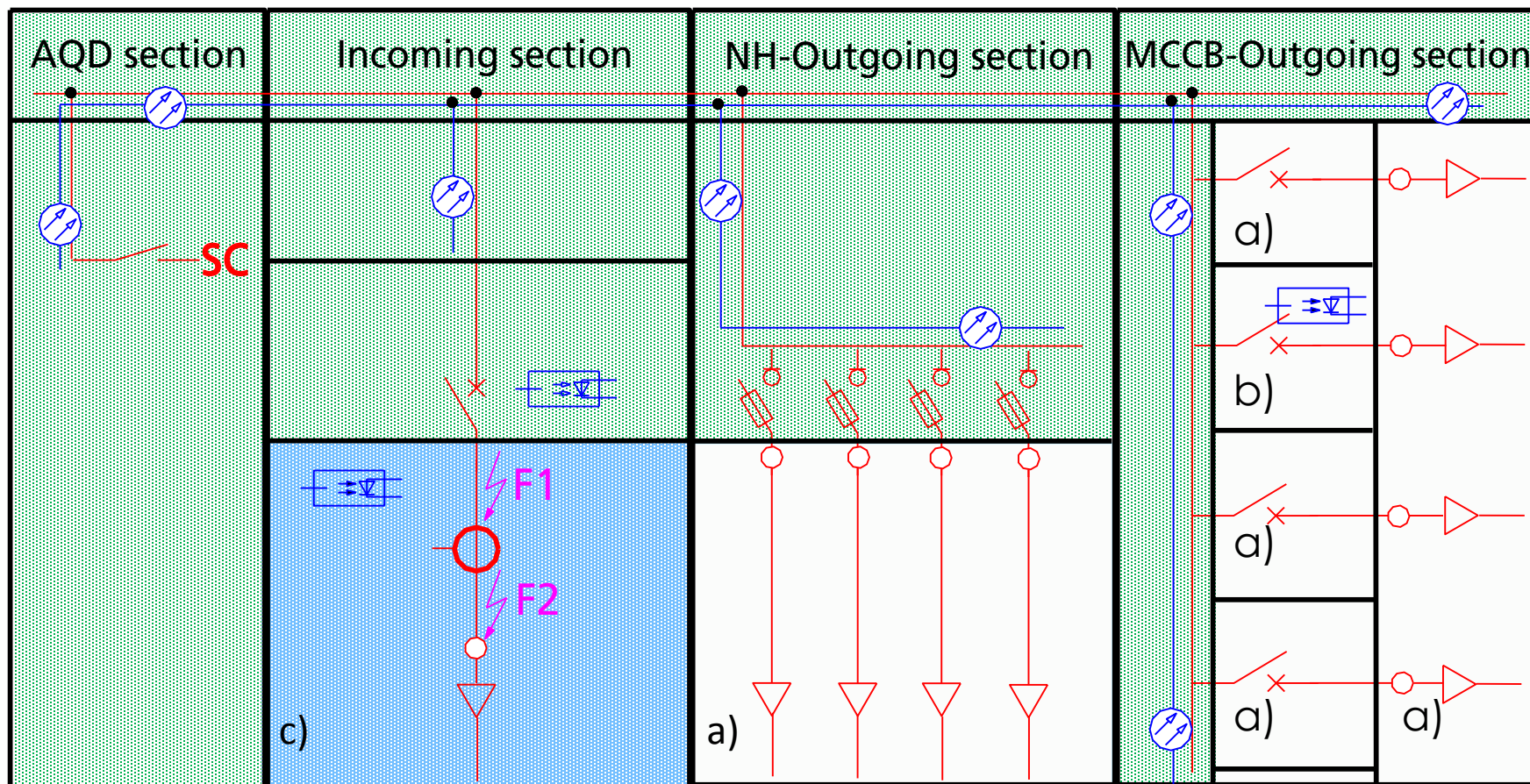
Protected and non-protected areas

The declaration of each IAMS-protected area includes the following parameters:

- Range of the prospective short-circuit current that is present at the input terminals of the PSC-assembly.
- The range of rated operational voltages correlating to the range of the prospective short-circuit current.
- The highest arc energy that has been determined as electrical energy in the design verification tests.

Protected and non-protected areas

Example for an optical based IAMS and an AQD as IARD



IAMS-protected area

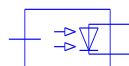
Non IAMS-protected area

Conditionally IAMS-protected area

- a) No sensor
- b) Sensor is installed but unintended operation by switching arc is possible
- c) Sensor is installed but the correct functioning depends on the location of the fault, the switching status of the incoming switch and the effect of any back-up protection that may be present



Fibre optic sensor



Point sensor

SC Short-circuit

F1, F2

Fault locations

1. Integration in the international standard system

2. Scope

3. Components and basic structure

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5. Design verification

Design Verification

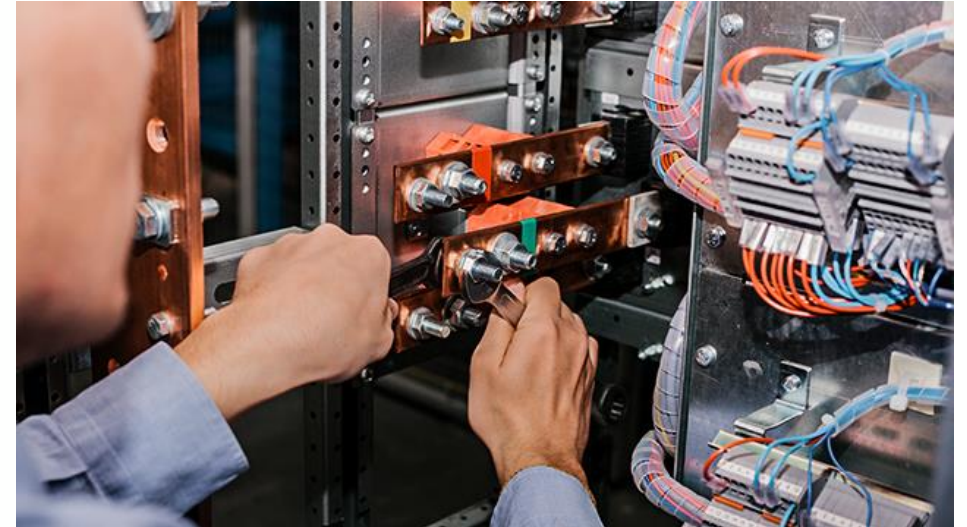
The complete design verification acc. to IEC 61439-2 includes the following:

a) Construction

- 10.2 Strength of materials and parts
- 10.3 Degree of protection of enclosures
- 10.4 Clearances and creepage distances
- 10.5 Protection against electric shock and integrity of protective circuits
- 10.6 Incorporation of switching devices and components
- 10.7 Internal electrical circuits and connections
- 10.8 Terminals for external conductors

b) Performance

- 10.9 Dielectric properties
- 10.10 Verification of temperature rise**
- 10.11 Short-circuit withstand strength**
- 10.12 Electromagnetic compatibility
- 10.13 Mechanical operation



The technical standard specifies some additional tests to demonstrate the correct functioning of the entire arc protection system under built-in conditions.

Design verification-Additional tests

10.10.1 Additional tests to verify the temperature-rise

10.11.1 Additional tests to verify the short-circuit

withstand strength of the AQD-circuit (wanted, internal, metallic short-circuit)

10.101.2 Verification of arc-fault detection by test

10.101.3 Verification by test that unintended operation

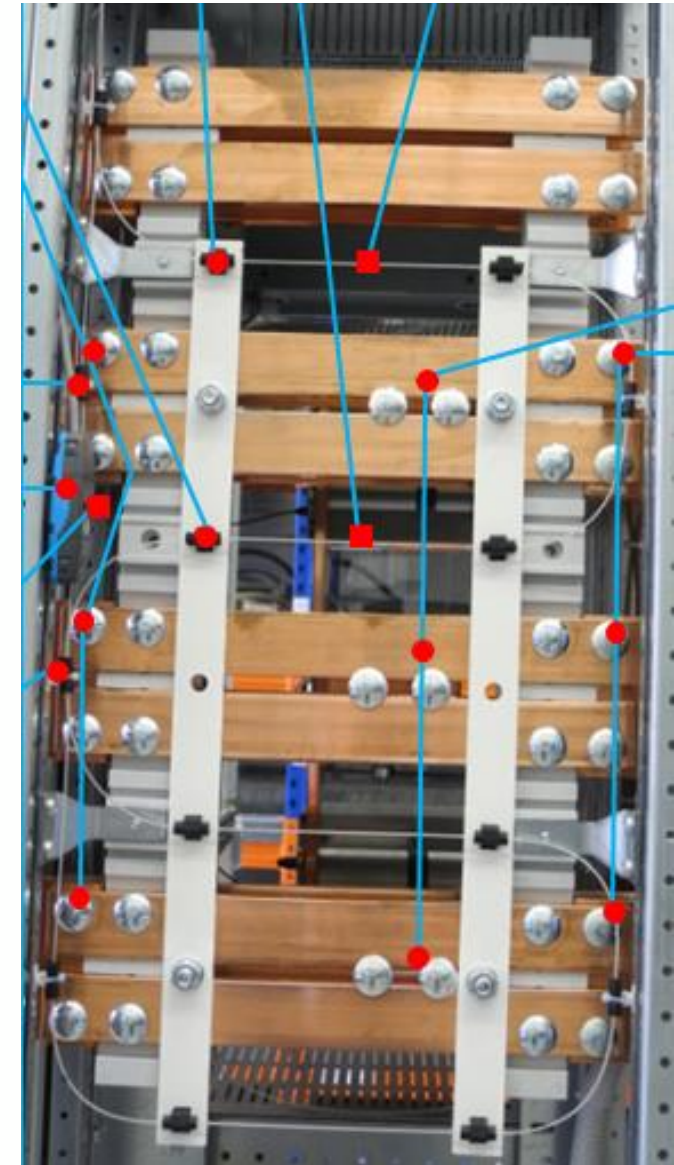
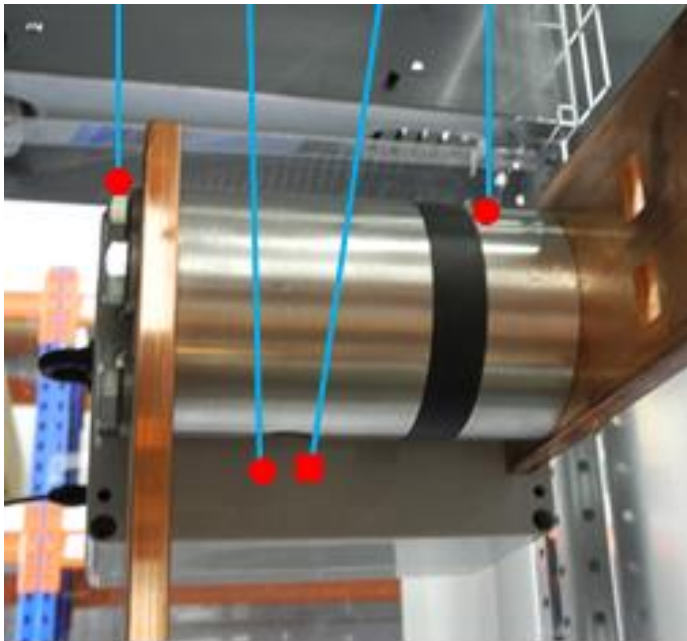
will not occur

10.101.4 Verification of an IAMS in PSC-assemblies by test

10.101.5 Performance after powering or repowering

Design verification-Temperature-rise test

Temperature measuring points on the optical sensors
and on the AQD



By courtesy of Siemens AG and DEHN SE+Co KG

Design verification-Short-circuit test

10.11.1 General

Addition:

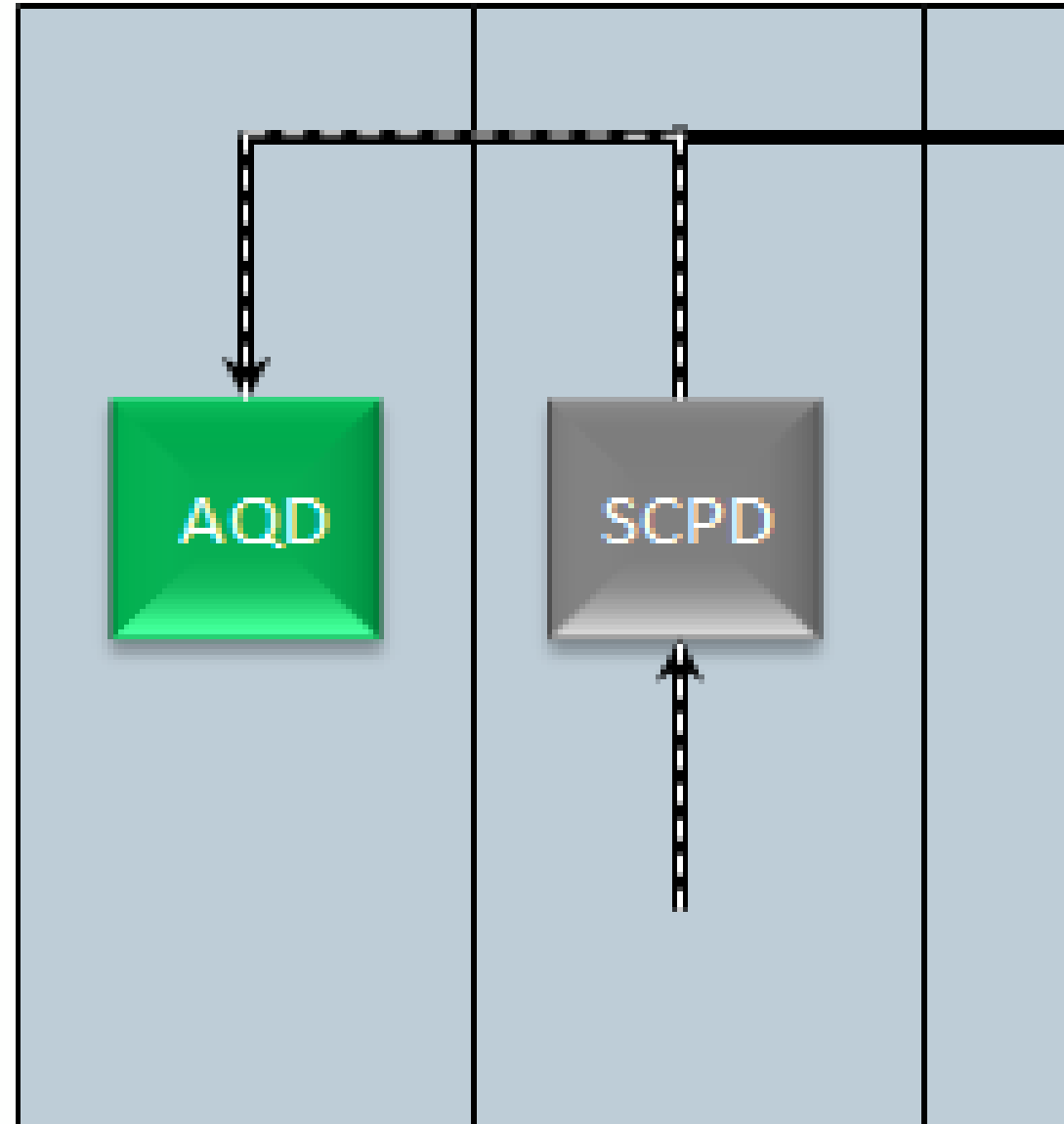
If present, the AQD main circuit including the incoming circuit and the connection to the connection point of the AQD have to be tested.

10.11.5.5 Evaluation

Addition:

In applications with an IAMS using an AQD, no crack(s) within the busbar system are allowed.

Note: The use of resettable (Reusable) AQD can draw additional requirements.



Design verification-Arc fault detection

For the lowest rated operational voltage, this test has to be carried out with the lowest, single-phase short-circuit current declared by the manufacturer. The ignition of the arc should take place at the point of an IAMS-protected area at which the occurrence of an arcing fault is most likely.

If the manufacturer does not specify a minimum short-circuit current value, the test should be carried out with 10 kA.

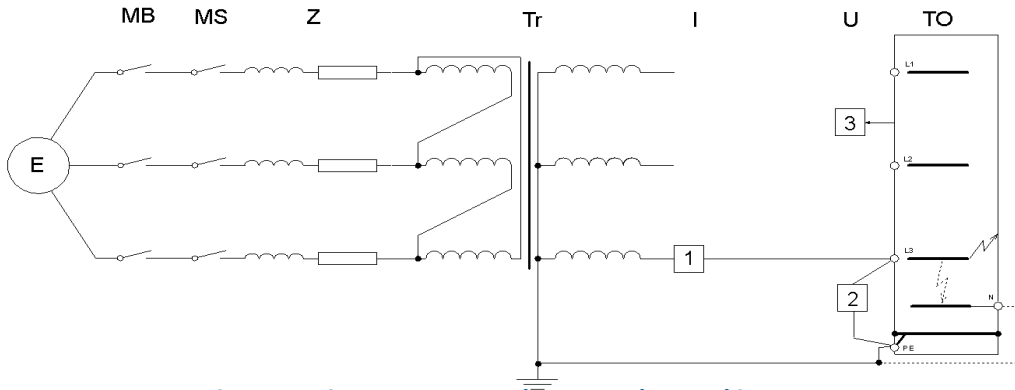
In addition, unfavorable conditions such as shading of the sensor have to be taken into account. This is particularly the case with internal separations and in cable outlets.

Design verification-Arc fault detection

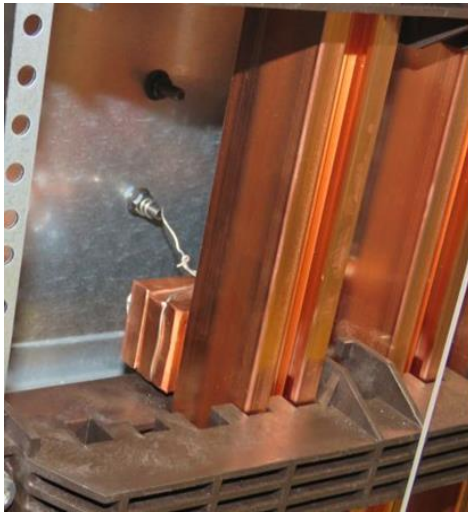
Ignition points

Network	Number of phases	Number of active conductors	Ignition between
TN-C	1	2	L and PEN
	3	4	LX and PEN
TN-S	1	2	L and PE or N
	3	4	LX and PE or N
TT	1	2	L and N
	3	3	LX and LY
	3	4	LX and N
IT	1	2	L1 and L2
	3	3	LX and LY
	3	4	LX and N

Design verification-Arc fault detection



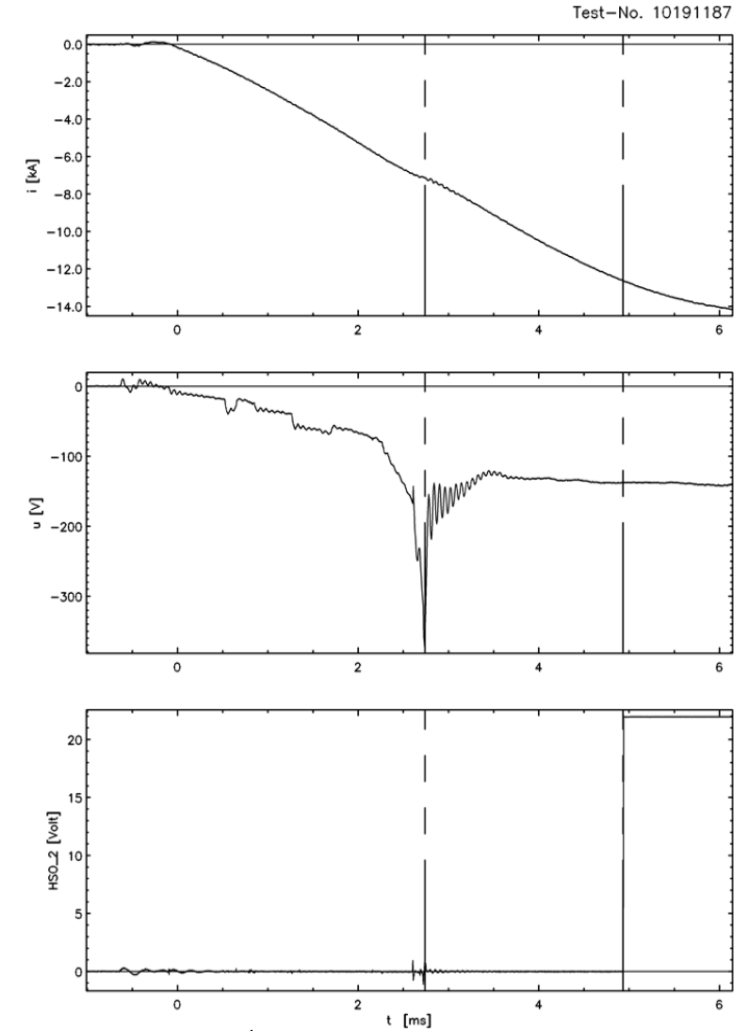
Test and measuring circuits



Ignition point



Status indication



Oscillogram

By courtesy of Siemens AG and DEHN SE+Co KG

Design verification- Verification that unintended operation will not occur

Switching arcs emit e.g. light and heat with an accompanying increase in pressure, which, depending on the sensor system, **can cause an unwanted activation** of the arc protection system.

Air-insulated switches have to be considered for the operating conditions short circuit, overload and normal load.

If circuit breakers are installed as SCPD, the test has to be carried out with the highest let-through energies, i.e.:

- with the highest prospective short-circuit current and the corresponding rated operational voltage as well as
- at the highest setting of the overcurrent releases as specified by the manufacturer.

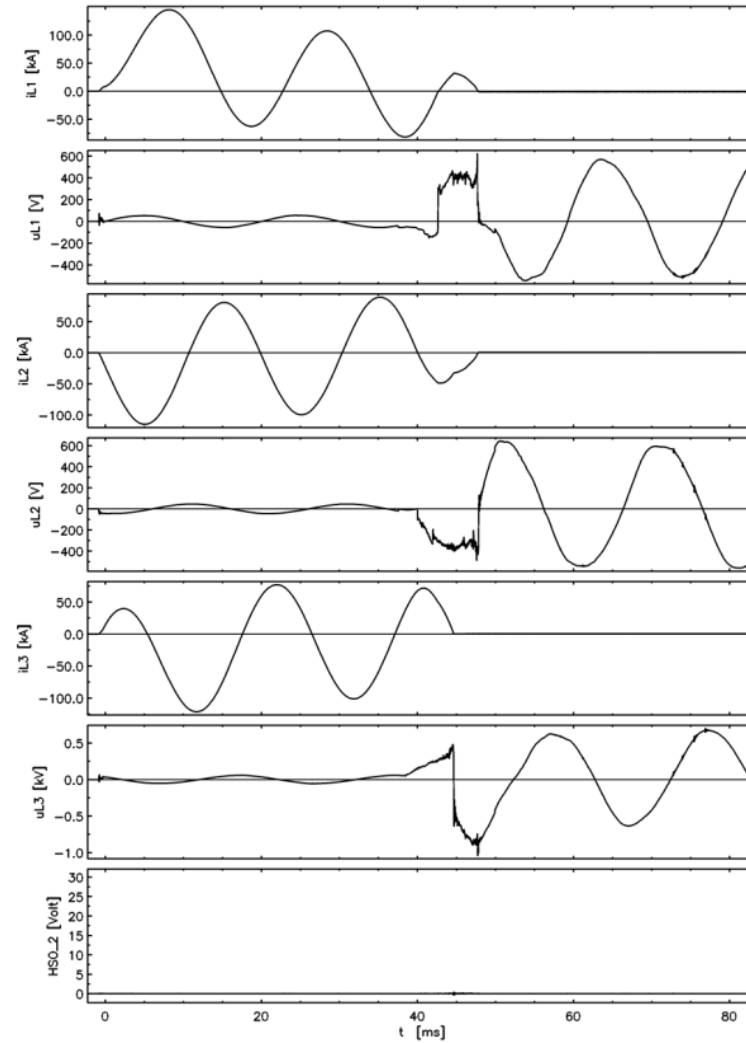
Design verification- Verification that unintended operation will not occur

The test has to be carried out with the intended switchgear that delivers the greatest emissions. The safety distances to earthed metal parts can provide an indication of this.

Design verification- Verification that unintended operation will not occur



Circuit-breaker section



Oscillogram



Status indication

By courtesy of Siemens AG and DEHN SE+Co KG

The intend of this test is to demonstrate that the entire IAMS is functioning correctly. In addition, the arcing energy released within the switchgear (purely electrical) has to be determined.

If circuit breakers are installed as SCPD, the test must be carried out with the highest let-through energies, i.e.:

- with the rated short-circuit current and the rated short-time current at the corresponding rated operational voltage as well as
- at the highest release settings as specified by the manufacturer.

Note: The test can be carried out in conjunction with IEC TR 61641.

Design verification- Verification of an IAMS in PSC assemblies by test

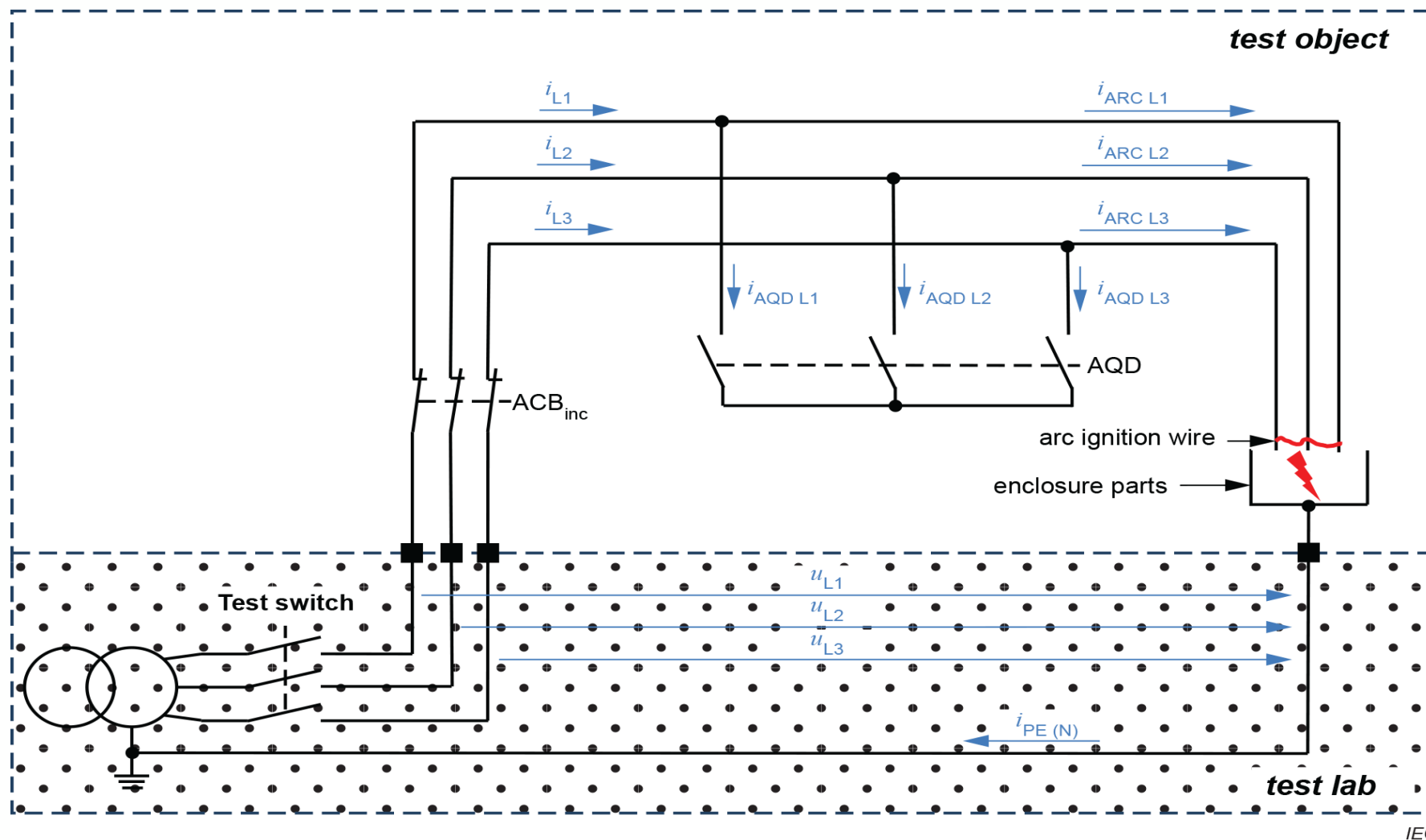
The arc has to be ignited three pole in three-phase systems . In single phase systems as follows :

Network	Ignition between
TN-C	L and PEN
TN-S	L and PE or N
TT	L and N
IT	L1 and L2

The test (ignition) has to be carried out in the IAMS-protected area that is closest to the incoming terminals.

Design verification- Verification of an IAMS in PSC assemblies by test

Description of the extinction of an internal arc-fault by an IAMS using an AQD as IARD
(Annex JJ)



The following sequence of events will occur:

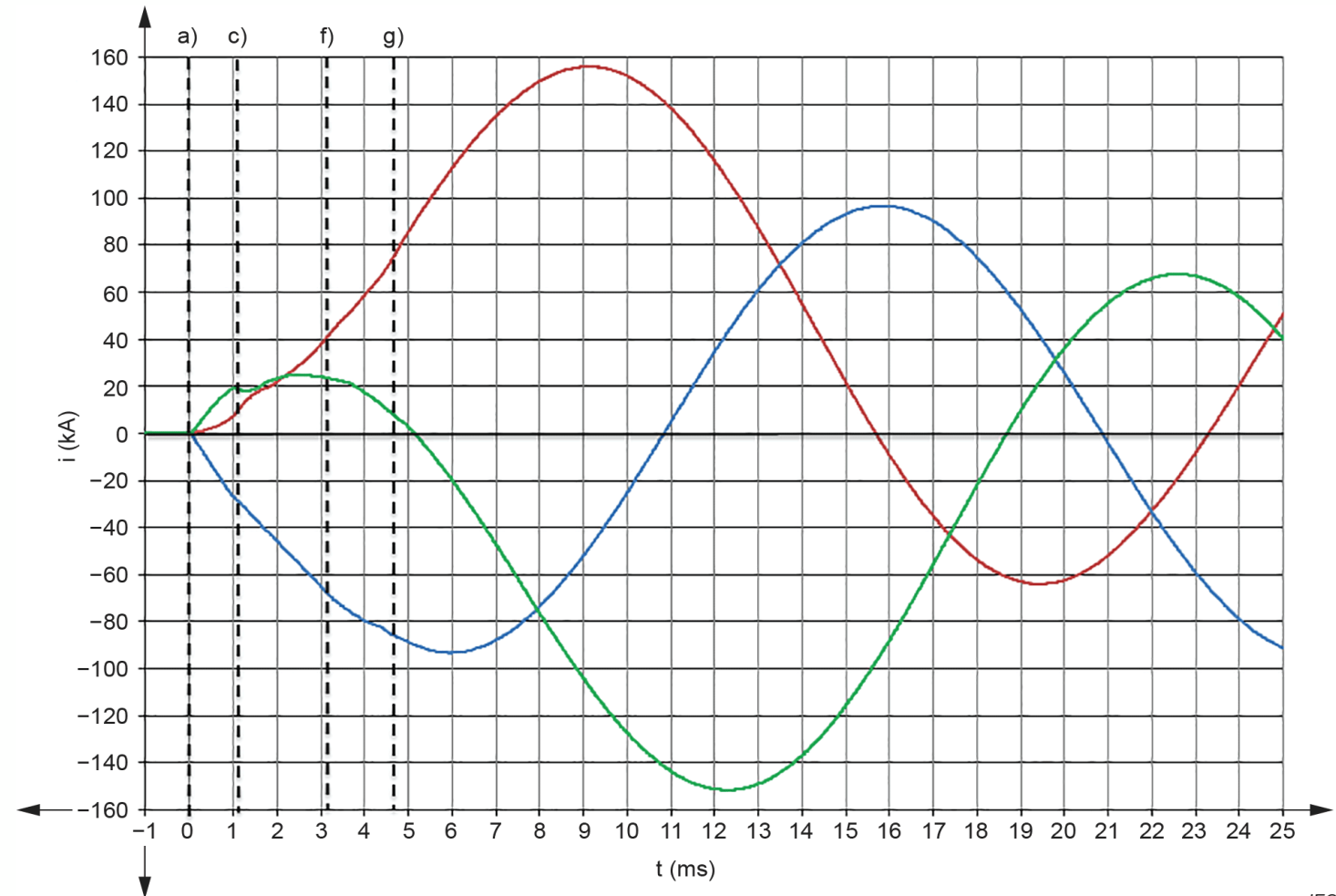
- a) Test switch (making switch of the test laboratory) is closed.
- b) The arc-ignition wire is melting.
- c) The arc is ignited (time t_o in accordance to IEC 60947-9-2).
- d) The arc is recognized by the IACD.
- e) Only AQD or both, AQD and incoming SCPD are triggered by the IACD.
- f) The low-impedance state of the AQD is established.
- g) The current is almost completely commutated into the AQD circuit.
- h) The incoming SCPD has cleared all line currents.

Note: Due to the definition of t_o , the event d) can occur before c).

Design verification- Verification of an IAMS in PSC assemblies by test

Currents in the incoming circuit

- a) Test switch (making switch of the test laboratory) is closed.
- c) The arc is ignited (time t_o in accordance to IEC 60947-9-2).
- f) The low-impedance state of the AQD is established.
- g) The current is almost completely commutated into the AQD circuit.

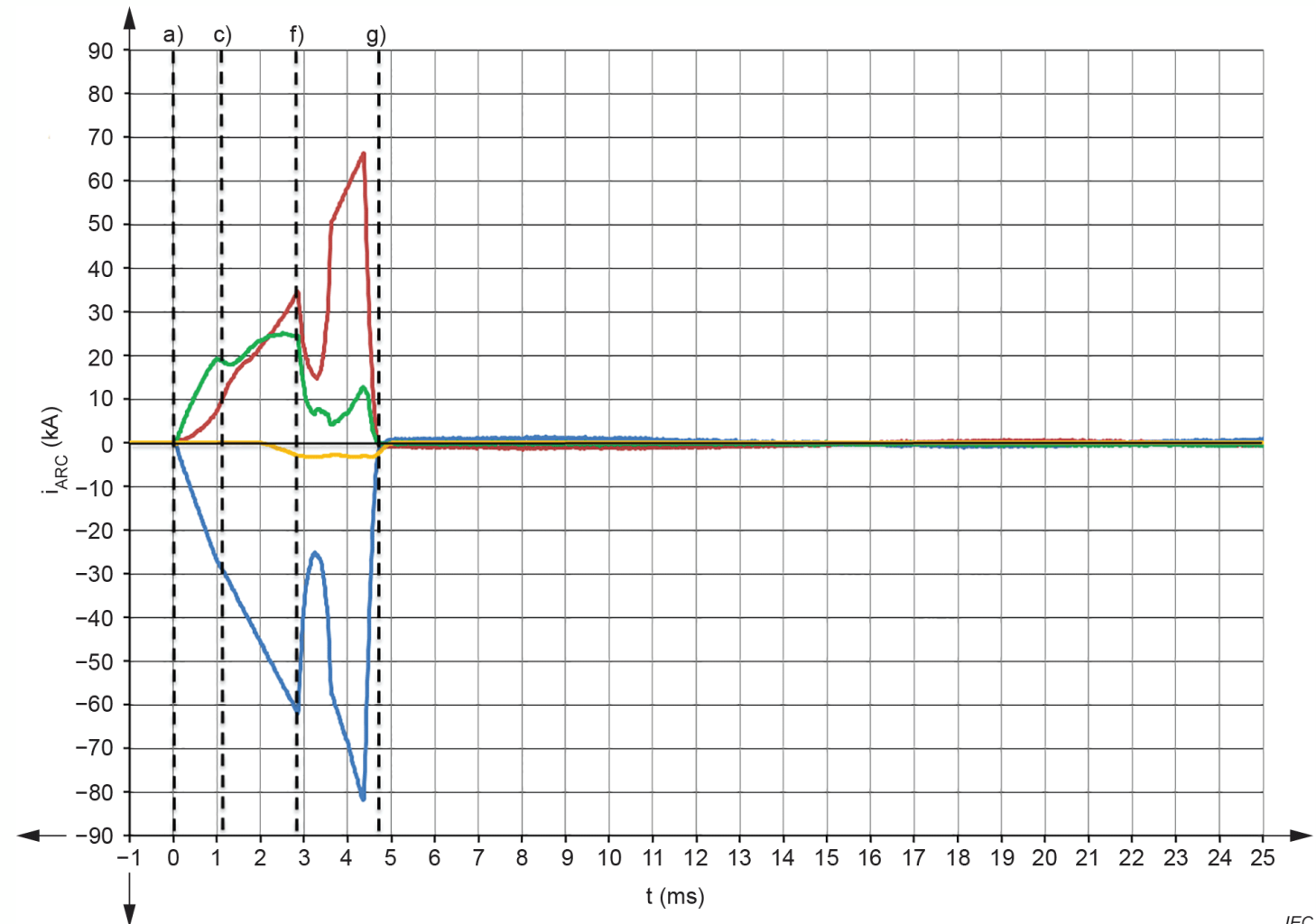


IEC

Design verification- Verification of an IAMS in PSC assemblies by test

Currents in the arc-fault circuit

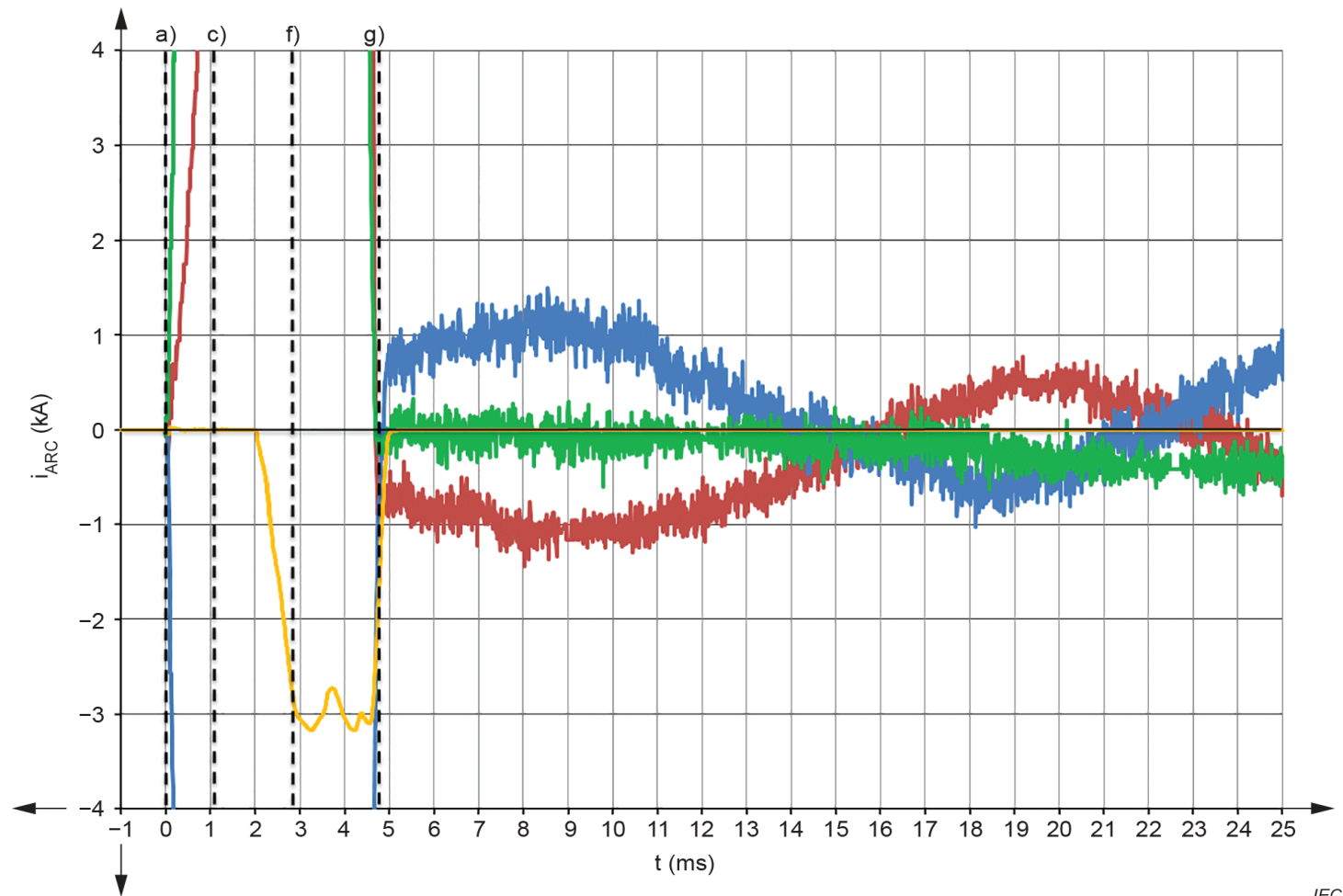
- a) Test switch (making switch of the test laboratory) is closed.
- c) The arc is ignited (time t_0 in accordance to IEC 60947-9-2).
- f) The low-impedance state of the AQD is established.
- g) The current is almost completely commutated into the AQD circuit.



Design verification- Verification of an IAMS in PSC assemblies by test

Currents in the arc-fault circuit (magnified scale)

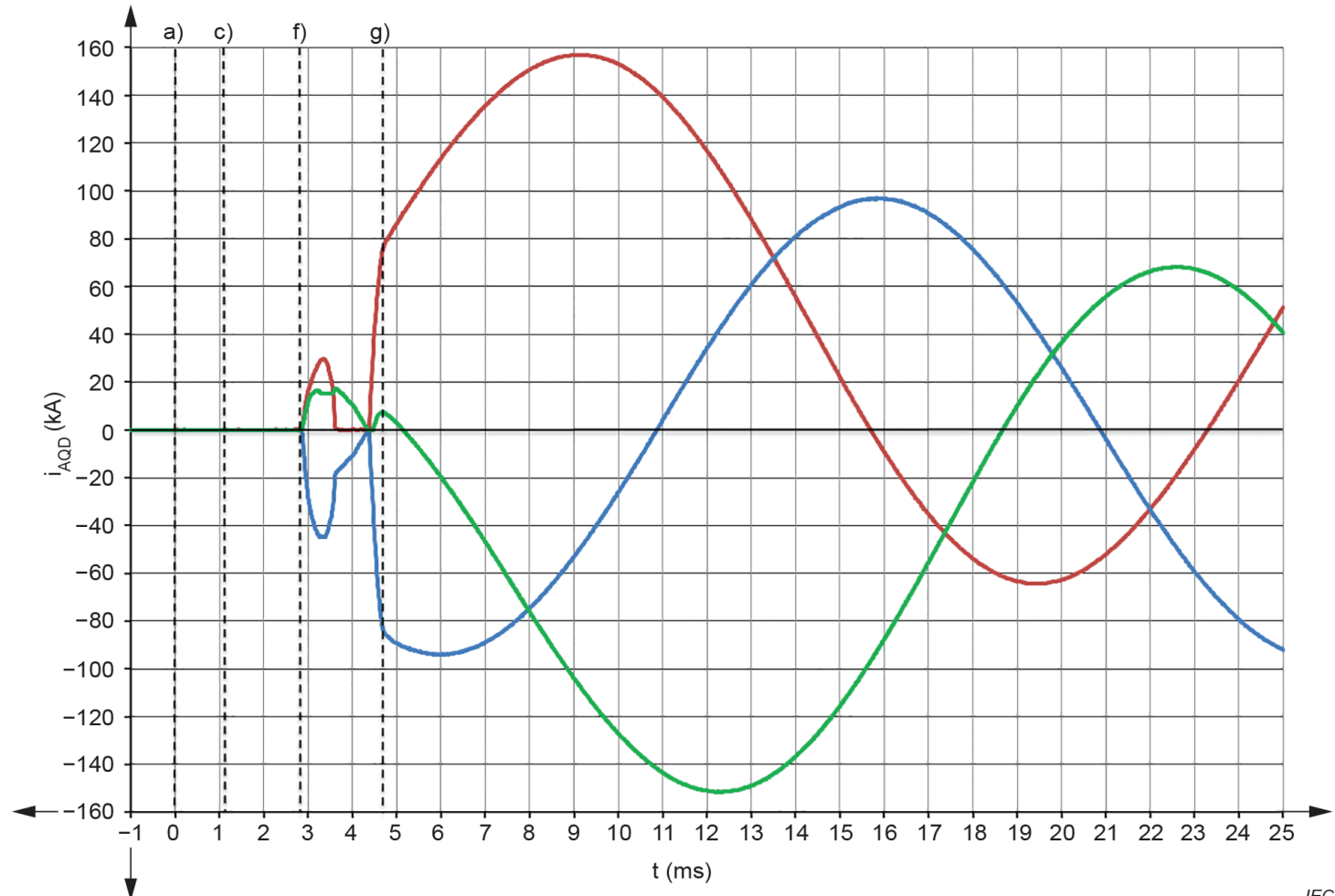
- a) Test switch (making switch of the test laboratory) is closed.
- c) The arc is ignited (time t_0 in accordance to IEC 60947-9-2).
- f) The low-impedance state of the AQD is established.
- g) The current is almost completely commutated into the AQD circuit.



Design verification- Verification of an IAMS in PSC assemblies by test

Currents in the AQD circuit

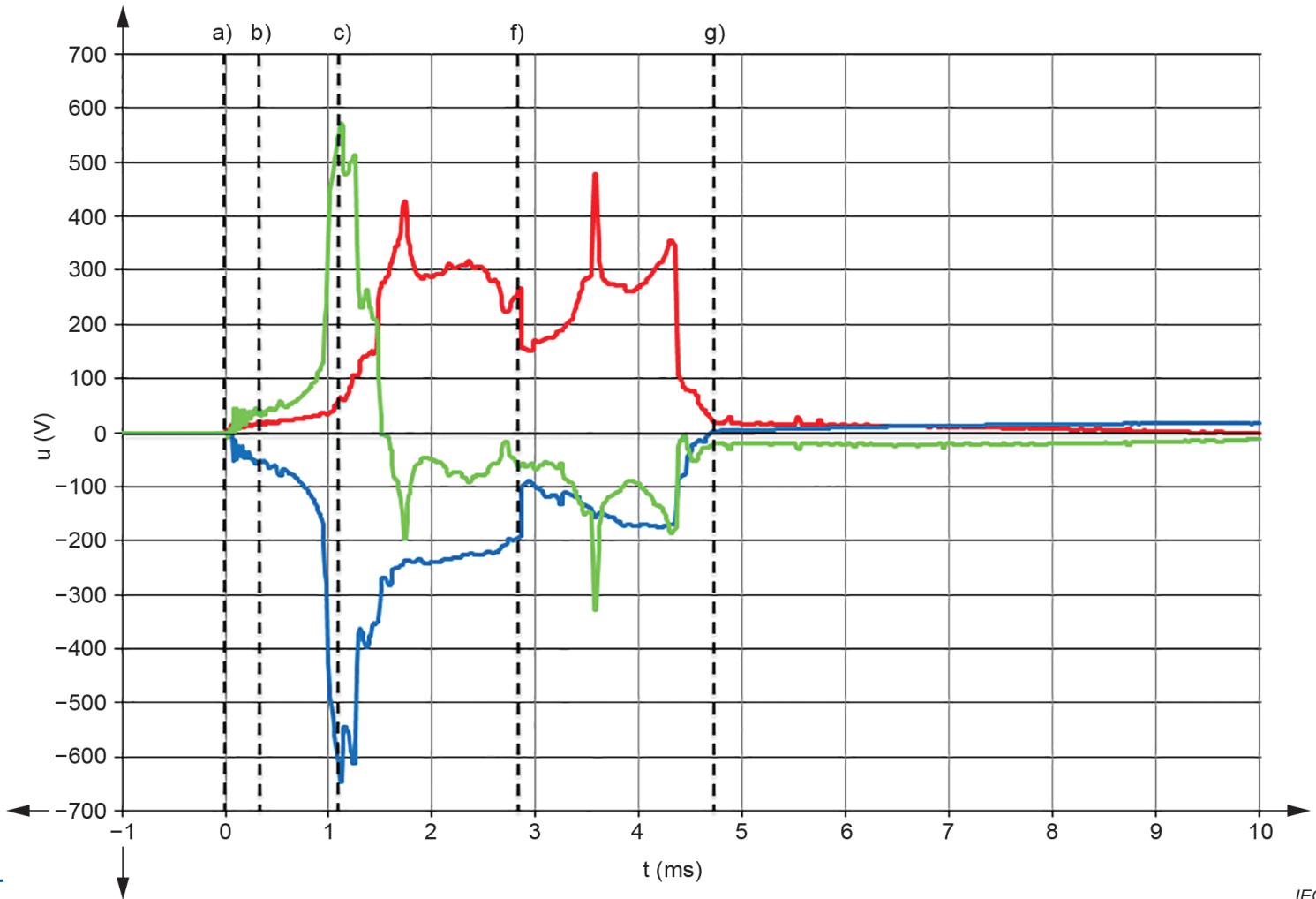
- a) Test switch (making switch of the test laboratory) is closed.
- c) The arc is ignited (time t_0 in accordance to IEC 60947-9-2).
- f) The low-impedance state of the AQD is established.
- g) The current is almost completely commutated into the AQD circuit.



Design verification- Verification of an IAMS in PSC assemblies by test

Voltages at the incoming terminals

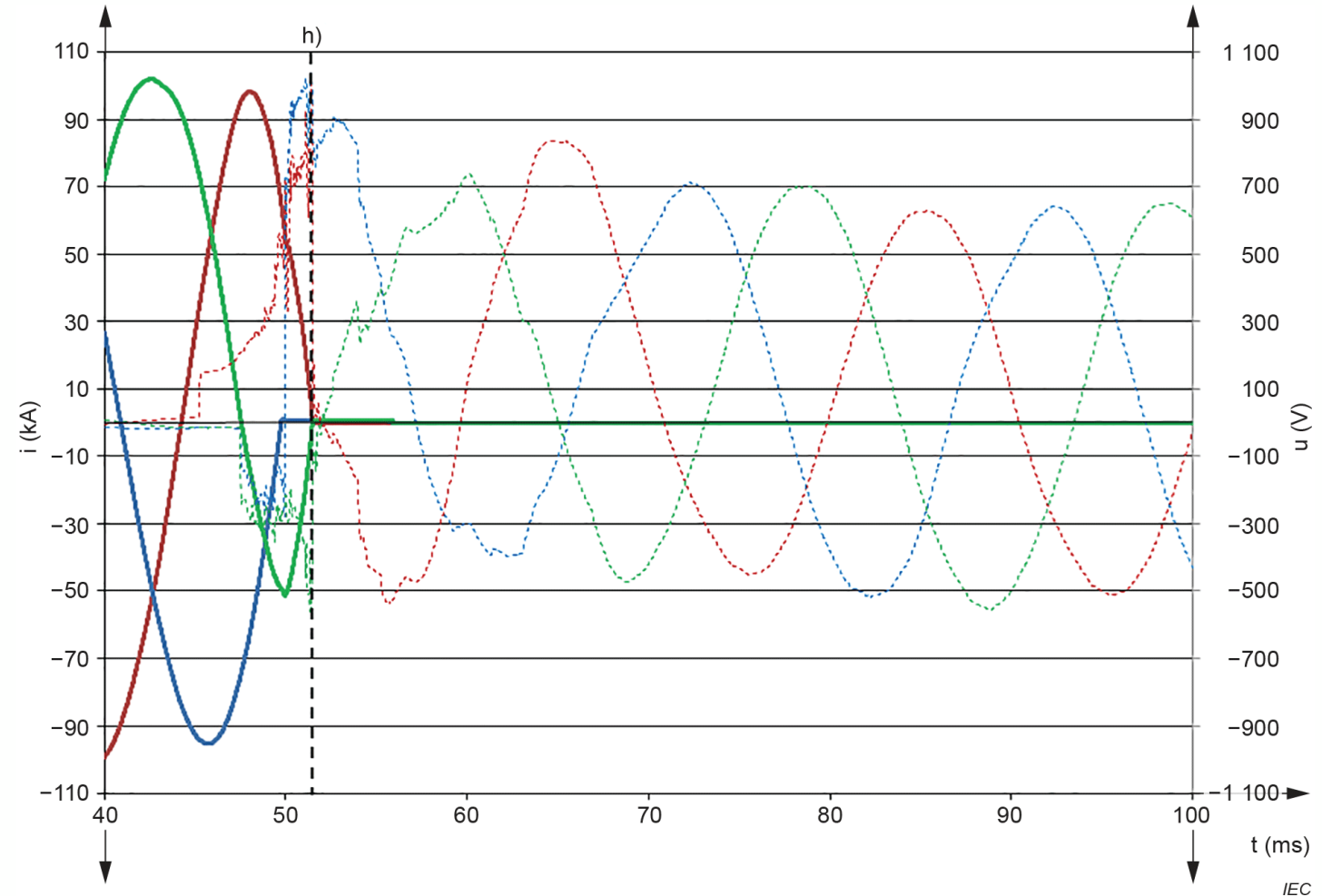
- a) Test switch (making switch of the test laboratory) is closed.
- b) The arc-ignition wire is melting.
- c) The arc is ignited (time t_0 in accordance to IEC 60947-9-2).
- f) The low-impedance state of the AQD is established.
- g) The current is almost completely commutated into the AQD circuit.



Design verification- Verification of an IAMS in PSC assemblies by test

Voltages at the incoming terminals (dotted curves) and incoming currents at the end of sequence

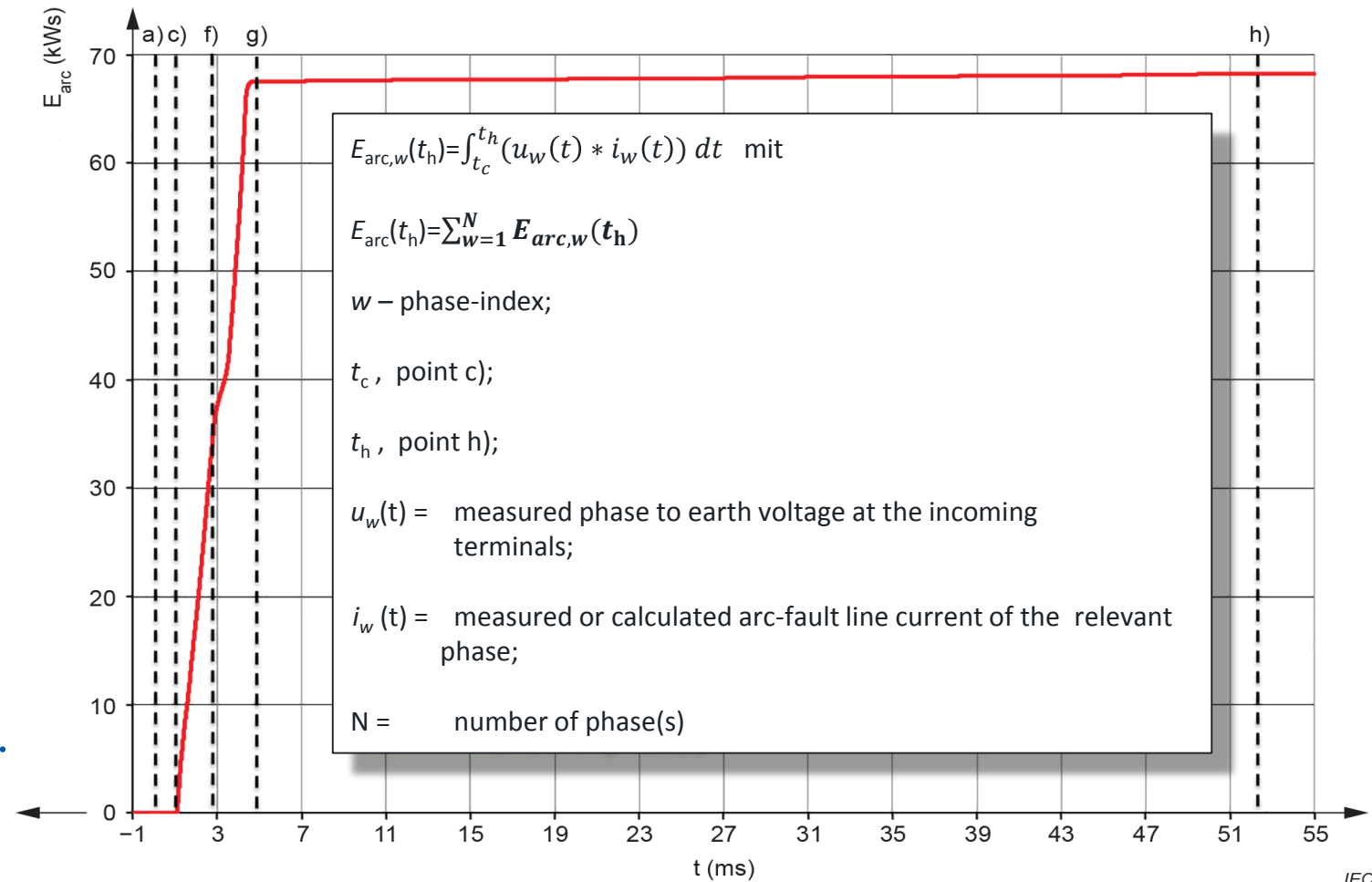
h) The incoming SCPD has cleared all line currents.



Design verification- Verification of an IAMS in PSC assemblies by test

Effective limitation of the increase in arc-energy

- a) Test switch (making switch of the test laboratory) is closed.
- c) The arc is ignited (time t_o in accordance to IEC 60947-9-2).
- f) The low-impedance state of the AQD is established.
- g) The current is almost completely commutated into the AQD circuit.
- h) The incoming SCPD has cleared all line currents



Many thanks for your attention

Ronald Borchert



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16, April, 2020 - Webinar

IEC TS 63107

**Integration of arcing fault mitigation
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KEMA Labs

Q&A

KEMA Labs

Thank you

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<http://www.kema.com>